

## Europium Complexes as Luminescent Sensitizers in Near-Infrared Persistent Phosphors

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Current research on the development of rare-earth-doped luminescent materials using luminescent sensitizers in the form of organic ligands or dyes aims to increase light absorption and tune emission by energy transfer *via* the antenna effect. [1,2] Hence, in this work, we propose the investigation of the *tris*-Eu<sup>3+</sup> thenoyltrifluoroacetate (tta) complex as a luminescent sensitizer in novel near-infrared (NIR) persistent phosphors. To synthesize these materials, firstly the europium complex was prepared by precipitation of a solution containing the tta ligand and europium chloride utilizing NH<sub>4</sub>OH. Then, a Cr<sup>3+</sup>-doped mixed Zn/Mg/Sn oxide (ZMSC) persistent phosphor was prepared by the ceramic method, sintering the oxide precursors at 1200 °C. Finally, the Eu<sup>3+</sup> complex was functionalized on the persistent phosphor by microwave-assisted surface silanization using 3-Aminopropyltrimethoxysilane. Powder X-ray diffraction results revealed an inverse spinel structure of the inorganic phosphor accounting for the formation of M<sub>2</sub>SnO<sub>4</sub> (M: Zn and Mg) in addition to a broad band assigned to the formation of a SiO<sub>2</sub> amorphous polymeric shell which supports coordination with the europium complex. UV-Vis and luminescence spectroscopy measurements were performed to probe the band gap energy and electronic transitions, where efficient Eu<sup>3+</sup> to Cr<sup>3+</sup> energy transfer was observed by ligand sensitization. Furthermore, X-ray fluorescence (XRF), X-ray absorption near edge structure (XANES), and X-ray excited optical luminescence (XEOL) experiments were carried out using synchrotron radiation (Fig. 1), where Cr and Eu distribution were investigated alongside the absorption and emission profiles under Cr K-edge and Eu L-edge, further supporting the efficiency of the Eu<sup>3+</sup> complex to sensitize NIR luminescence.

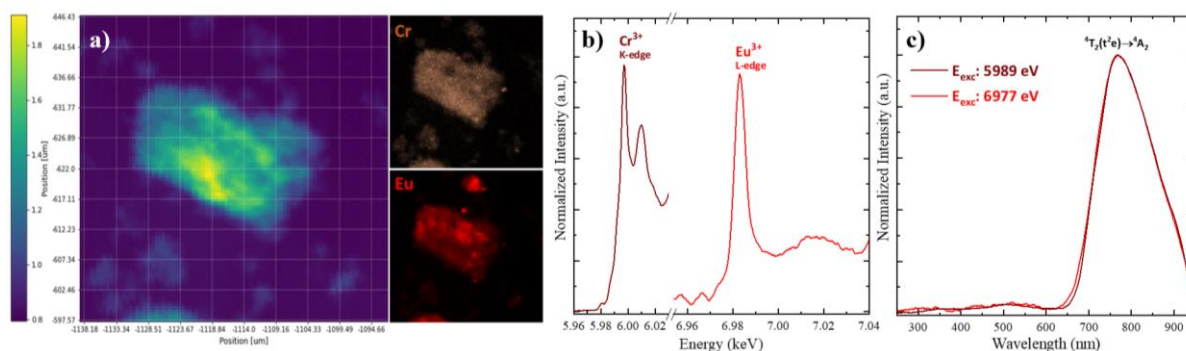


Fig. 1: a) XRF maps filtered for Cr and Eu distribution. b) XANES and c) XEOL spectra recorded under both Cr K-edge and Eu L-edge of ZMSC@SiO<sub>2</sub>-Eu(tta)<sub>3</sub> persistent phosphor.

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### References

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